Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/735,971	O'DAY, RICHARD F.	O'DAY, RICHARD F.	
Examiner	Art Unit	Art Unit	
Paul D. Kim	3729	3729	

	SEAR	CHED	
Class	Subclass	Date	Examiner
29	592.1 602.1 603.03 603.04	8/1/2006  -	PK
	606 607		
360	264.7		
	264.9		
	266.4		
	294.5	*	

INT	ERFERENC	E SEARCHI	ED
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Text Search EAST/NPL (IEEE)	8/1/2006	РК
Updated Text Search EAST/PGPub	1/18/2007	РК
-		
	,	